

<b>Notice of References Cited</b>	Application/Control No. 10/719,017	Applicant(s)/Patent Under Reexamination FUJII, SHUJI	
	Examiner Jinhee J. Lee	Art Unit 2831	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,222,134 B1	04-2001	Aoyama et al.	174/158R
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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